

<b>Notice of References Cited</b>	Application/Control No. 10/802,927		Applicant(s)/Patent Under Reexamination NAKANO ET AL.	
	Examiner JASON K. GEE		Art Unit 2434	Page 1 of 1

#### U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2004/0190868	09-2004	Nakano et al.	386/094
*	B	US-2001/0029608	10-2001	Nagashima et al.	725/2
*	C	US-2003/0012098	01-2003	Sako et al.	369/47.12
*	D	US-2002/0015494	02-2002	Nagai et al.	380/201
*	E	US-2003/0051153	03-2003	Andreaux et al.	713/200
*	F	US-2002/0059522	05-2002	Hirano et al.	713/193
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

#### FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

#### NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)			
	U				
	V				
	W				
	X				

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.